

Nanomechanical Properties of Rough Surfaces

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The nanoindentation technique allows the determination of mechanical properties at nanometric scale. Hardness (H) and elastic modulus (E) profiles are usually determined by using the Oliver-Pharr method from the load/unload curves. This approach is valid only for flat surfaces, or at least, when a very low degree of asperity is present (lower than 30 nm). The basic statement is the determination of the zero tip-surface contact point. If a rough surface is present, errors can occur in determining this contact point and, as a consequence, the surface hardness and elastic modulus profiles are drastically altered resulting in under evaluated values. Surfaces with different roughness were produced by controlled nitrogen glow discharge process on titanium. The changed nitriding parameters were different N_2/H_2 atmospheres and temperatures (600 °C-900 °C). The most correct H and E profiles were obtained by using the contact stiffness analysis method, proposed here, that overcomes the surface roughness. The obtained results were compared with available literature data.

Keywords: nanoindentation, roughness, nitriding, titanium

1. Introduction

The nanoindentation technique allows the determination of the surface mechanical properties in nanometric scale. Hardness and elastic modulus can be calculated by using the method proposed by Oliver and Pharr^{1,2}. This method relates applied load, tip displacement and time, and all of them are measured by sensors while a diamond-tip penetrate the material surface (depth sensing method or instrumented indentation). For thin films or modified layers at near surface, it is possible by nanoindentation technique to investigate hardness (H) and elastic modulus (E) profiles at very shallow depths (on the order of nm) up to deeper regions (on the order of μm)³. In the Oliver-Pharr method, the surfaces must be as flat as possible because the method is strongly dependent of the contact stiffness between the tip and the sample surface to start the data acquisition onset to build the loading/unloading curves.

It is well known that surface modifying processes such as nitrogen glow discharge and nitrogen plasma immersion ion implantation (PIII) can produce high surface roughness due to sputtering effects that depend on the surface nature, ion energy and working temperature⁴. However, almost of all surface hardness profiles reported in the literature were measured through the microhardness tests, when the surface roughness degree is less important to obtain these profiles.

Odo and Lepiński⁵ reported a study about hardness and elastic modulus surface profiles, using nanoindentation technique, in different rough surfaces (soda-lime glass, Al and nitrided Ti). The authors recalculated from the experimental loading curve a new loading/unloading curve that does not take into consideration the effect of the surface roughness. In this method the load vs. depth plot is fitted by a power law function to know the zero surface contact point. The hardness is then calculated from the first derivatives of the loading/unloading curve.

In the present work we propose another method to minimize the surface roughness effect on the loading/unloading curves obtained from the instrumented indentation. The method is based on the analysis of the contact stiffness between the tip and the sample surface, taking into account the mean surface roughness and the most actual elastoplastic deformation. After that, the well-known Oliver and Pharr method¹ is then applied. The analyzed rough surfaces were titanium ion nitrided in different conditions of atmosphere and temperature. The hardness and elastic modulus profiles obtained by the present proposed method are also compared to the Odo-Lepiński method⁵ in addition to Vickers measurements. Major details about mechanical properties of ion-nitrided titanium can be found in de Souza et al.⁶

2. Materials and Methods

Commercial pure titanium samples were cut from a 2.0 cm diameter ingot in thickness of 0.3 cm. In order to obtain flat and less surface stresses, the samples were electrochemically polished in an HClO_4 solution and then cleaned in $(\text{CH}_3)_2\text{CO}$ and CCl_4 solutions.

The nitriding of the samples was performed in a conventional DC plasma device. Depending on the applied voltage, current and gas composition, different nitrided surfaces were obtained. The nitriding atmospheres were: 100% N_2 , 80% N_2 / 20% H_2 , 60% N_2 / 40% H_2 and 20% N_2 / 80% H_2 . For each of these gas mixtures, samples were then nitrided at 600 °C, at 700 °C, at 800 °C and at 900 °C. The temperature was ion current supplied and monitored by a backside thermocouple. The gas pressure ranged from 3 Pa to 10 Pa during the working conditions. The treatment time was 3 hours for all samples. According to the literature⁷⁻¹⁰, at the highest treatment temperature (900 °C), a

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modified region of up to 4 μm in thickness is obtained. The nitriding parameters are shown in Table 1.

Hardness and elastic modulus profiles were determined by a MTS Systems "Nano Indenter XP™" device. The applied loads changed from 12.5 mN to 400 mN. In order to have a representative ensemble, 40 indentations per sample separated 50 μm to each other were performed. The diamond tip was a Berkovich type. In order to reach deeper regions (substrate), Vickers microhardness measurements were performed in a Carl Zeiss MHP-160 device, with loads ranging from 500 mN to 1600 mN. Surface roughness profiles were obtained by a Veeco/Sloan "Dektak3" profile meter.

3. Results and Discussion

Depending on the nitriding conditions, different titanium nitrides and titanium oxides can be formed (δ -TiN, ϵ -Ti₂N, TiO and TiO₂) in addition to a nitrogen solid solution region^{10,11} in the Ti matrix. X ray diffraction analysis, shown in the reference 6, confirms the presence of all of these phases as a function of the working conditions.

All of these phases have hardness higher than titanium substrate^{4,7-10,12}. Consequently, it is expected that the hardness profiles decrease with depth until reaching the substrate value. However, this typical hardness behavior was not obtained, as can be observed in Figure 1a (triangles symbols), which relates hardness with contact depth for the sample nitrided at 60%N₂ / 40%H₂ atmosphere and 800 °C, as calculated by the Oliver-Pharr method. These kinds of hardness profiles were obtained in all of the different nitriding atmospheres and high temperatures worked. Along with a big error bar in the hardness, it is also observed an enormous error in the respective tip depth. The average contact depth starts at ≈ 700 nm with hardness similar to Ti bulk hardness⁶ (≈ 4 GPa), it reaches around 7 GPa at ≈ 900 nm in depth and then decreases to ≈ 5 GPa at 2000 nm. Similar curve behavior was verified for the elastic modulus profiles, as can also be seen in Figure 1b for the same sample (triangles symbols). The surface elastic modulus is approximately constant until deeper regions, not making evident the existence of a nitrided layer. For

nitrided titanium, surfaces are expected to be stiffer than substrate, that is, with greater elastic modulus values.

In Figure 2 it is shown typical surface roughness profiles at different working temperatures for the samples nitrided at 80%N₂ / 20%H₂ atmosphere. This figure summarizes the roughness patterns for all working conditions. The mean roughness R_a was determined by using the expression^{4,13}

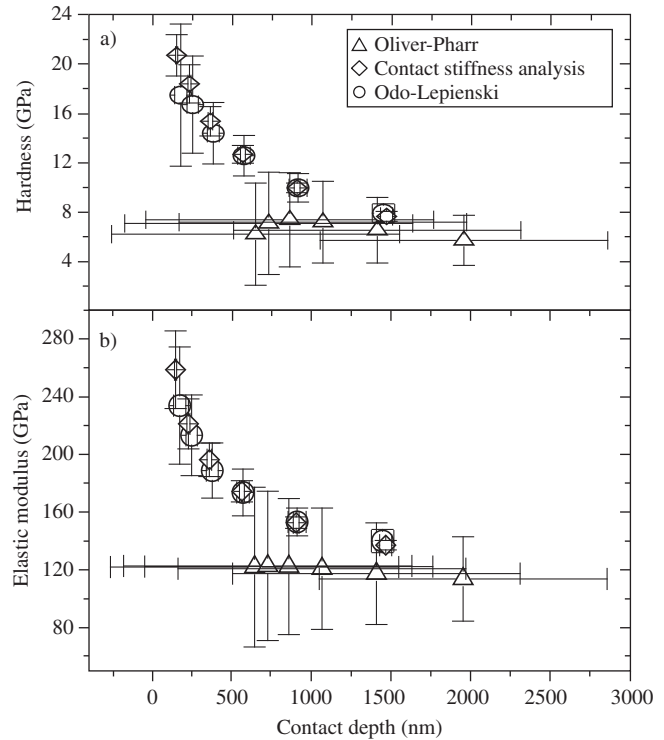


Figure 1. a) Hardness and b) elastic modulus vs. contact depth for titanium nitrided at 60%N₂ / 40%H₂ atmosphere and 800 °C: (Δ) not corrected (as obtained for the nanoindenter algorithm), (◇) according to the contact stiffness analysis correction and (O) the Odo-Lepienski method.

Table 1. Nitriding parameters and surface average roughness (R_a). All titanium samples were plasma nitrided during 3 hours.

Sample	Temperature (°C)	Atmosphere	R_a (nm)
As received	-	-	19.0 ± 8.6
1	600	100%N ₂	21.0 ± 5.4
2	600	80%N ₂ / 20%H ₂	18.4 ± 4.3
3	600	60%N ₂ / 40%H ₂	23.0 ± 6.1
4	600	20%N ₂ / 80%H ₂	22.0 ± 5.2
5	700	100%N ₂	33.3 ± 7.8
6	700	80%N ₂ / 20%H ₂	15.2 ± 4.2
7	700	60%N ₂ / 40%H ₂	68.9 ± 9.5
8	700	20%N ₂ / 80%H ₂	90.9 ± 32.5
9	800	100%N ₂	206.3 ± 30.3
10	800	80%N ₂ / 20%H ₂	77.3 ± 8.7
11	800	60%N ₂ / 40%H ₂	42.4 ± 15.4
12	800	20%N ₂ / 80%H ₂	68.4 ± 17.0
13	900	100%N ₂	48.3 ± 10.7
14	900	80%N ₂ / 20%H ₂	188.8 ± 67.8
15	900	60%N ₂ / 40%H ₂	235.7 ± 62.6
16	900	20%N ₂ / 80%H ₂	200.8 ± 53.9

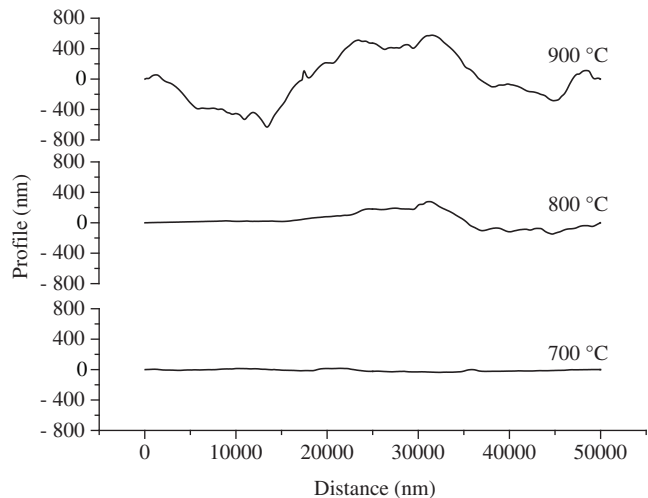


Figure 2. Surface profiles for the titanium samples nitrided at 80%N₂ / 20%H₂ atmosphere and different temperatures.

$$R_a = \frac{1}{L} \int_0^L |y(x)| dx = \frac{1}{N} \sum_{i=1}^N |y_i| \quad (1)$$

where L is the profile meter track length, N the number of data point, and y_i are the vertical deviations from a central line, which divides the profile so that the upper area is equal to the inferior one.

There are complicated relations between surface roughness patterns and working conditions (atmosphere composition and temperature), which are not our aim in this present study. As can be observed in Table 1, in average the surface roughness increases as a function of the working temperature. It was observed that the pure nitrogen atmosphere shows an irregular pattern for the surface roughness in comparing to the other atmospheres.

To understand different tip-surface approximation conditions, during a surface indentation, four different situations are shown in Figure 3: in the case a) a flat surface is indented, where no asperities are present or also for asperities for which R_a is much lower than the tip diameter (present situation $R_a \ll 100$ nm); in b) the tip reaches asperities with a diameter that is much greater than the tip curvature diameter^{14,15} - similar condition of reaching a great diameter valley; in the case c) the tip can slide through the asperity and the penetration onset is not determined correctly by the nanoindenter system; and in the case d) when the tip diameter is greater than the asperity diameter, and the first materials deformation may be plastic and not elastic. The last case can generate a nucleation of homogeneous dislocations under the contact point (high pressure), meaning a plastic deformation at the firsts indentation stages¹⁵. In the both last cases, the incorrect determination of the zero contact point increases the maximum tip penetration depth value (h_{max}) at the applied load, and consequently increasing the projected contact area (A) value for the ideal Berkovich tip, that is calculated by¹

$$A = 24,5h_c^2 \quad (2)$$

In this equation, h_c is the contact depth and it is related to h_{max} by $h_c = h_{max} - h_s$, where h_s corresponds to the surface displacement in the contact perimeter (elastic deformation).

Hardness is calculated by the expression^{1,16}

$$H = \frac{P_{max}}{A} \quad (3)$$

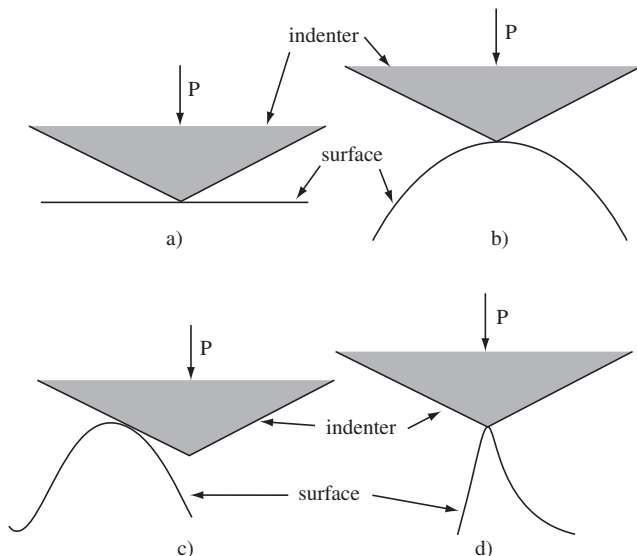


Figure 3. Different tip-surface approach. a) No asperities present (flat surface); b) asperities larger than tip diameter; c) tip sliding at the asperity; and d) asperity curvature diameter in the same order than tip diameter.

where P is the applied load. Consequently if roughness is present, H will be lower than the most actual one. This effect is very significant for small applied loads and for the cases when the mean roughness R_a is in the range of the tip penetration depth (similar to tip diameter, Figure 3c and 3d). The elastic modulus determination by means of the Oliver-Pharr method also depends strongly on the h_{max} value as can be observed in reference 1.

As cited above, in the present work we do not have interest to correlate surface roughness patterns to the plasma working parameters. The "Nano Indenter XP™" device allows obtain the tip to surface stiffness response during the tip penetration. This mechanical parameter can be associated to the surface roughness degree. For a flat surface the contact stiffness increases very quickly, exceeding drastically the device stiffness (around 100 N/m) meaning then an effective tip penetration in the surface. However, if roughness is present some fluctuations around the initial stiffness take place, even during the tip displacement. This typical contact stiffness fluctuation behavior, that not increases quickly, reveals the difficulty of the system in determine the most actual zero surface contact point, shifting the contact tip depth.

The relation between applied load (P) and tip displacement (h) can be written as¹

$$P = \alpha h^m \quad (4)$$

where α and m are constants, with m approximately equal to 2 for a Berkovich tip at a plastic regime and low loads¹.

This expression can be rewritten as

$$\log P = \log \alpha + m \log h \quad (5)$$

Figure 4 shows part of a loading curve, at very low load, for a typical situation that can be found for a rough surface. Figure 4a shows the as obtained curve ($P = \alpha h^m$) and Figure 4b the corresponding curve in logarithmic form (Equation 5). Two distinct fits for the m parameter are possible in the curve, one in the range from -8.8 to -8.3 (m_1), and another beyond -7.6 (m_2). Due to the fact that the Oliver and Pharr method is based on an m value in the order of 2, the second branch (m_2) of the $\log h$ data determine the new zero surface contact point as indicated in Figure 4b. The new corresponding tip depth will be then used to correct the surface zero point at the contact stiffness curve and so, hardness and elastic modulus will be recalculated by the Oliver and Pharr method.

This cutoff depth specifies now the new zero surface contact point and it is in some way correlated to the calculated R_a value of the surface for all treated samples. This depth in the contact stiffness curve is ever easily identified by the quick increase on its value. Beyond this depth the curve shows a normal behavior as for a flat surface.

In Figure 1 it is also shown the hardness and elastic modulus curves recalculated after correction based on contact stiffness (lozenges symbols). The error bar are now reduced mainly in its depths spreads, showing most expected values at near surface region in agreement with literature data^{4,7-10,12}.

In order to verify if the corrected values, obtained by the present analysis process, were not influenced by artifacts that can be introduced by this correction, it was also performed another correction recently introduced and based in the adjustment of the loading curve by using a power law function fitting (Odo-Lepienski method⁵). In this method, loading curves are fitted by a power law function:

$$P = C(h - h_0)^m \quad (6)$$

where P is the applied load and h denotes contact depth. The constants C , h_0 and m are obtained by fitting the loading curve using the least squares method, where it is not necessary to know the zero surface contact point. Hardness and elastic modulus are calculated using the first derivative of the loading and unloading vs. depth curves. The

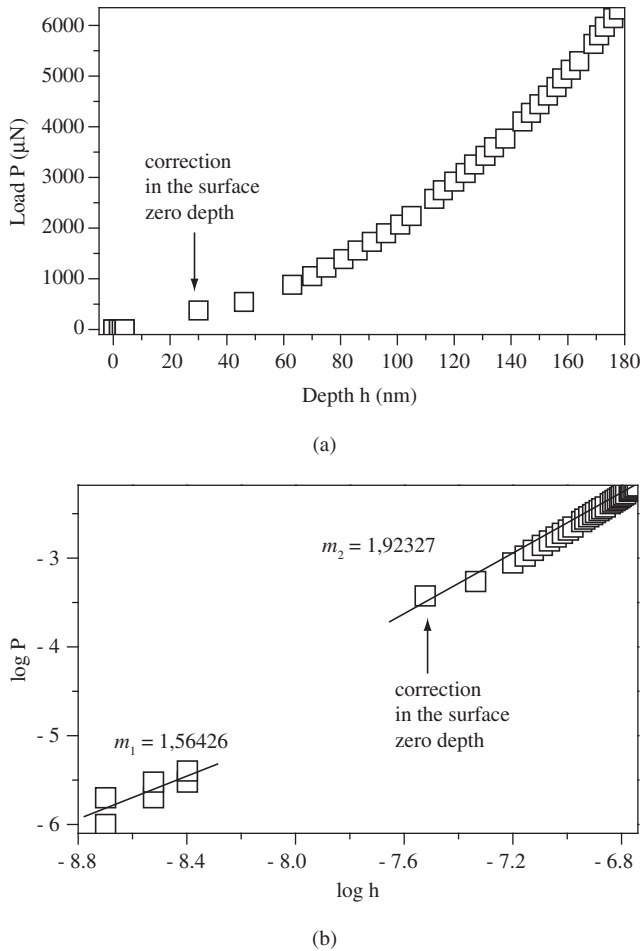


Figure 4. a) Initial portion of the loading curve; and b) the same curve linearized, for a nanoindentation test of the sample treated at 60%N₂ / 40%H₂ atmosphere and 600 °C. The arrows indicate the same experimental point in both plots.

Odo-Lepinski method is shown in Figures 1a and 1b, too (circles symbols). A very good agreement between this method and our method is observed.

To reinforce the recalculated hardness profiles by nanoindentation, Vickers microhardness measurements were also performed in all samples. Figure 5 shows simultaneously a typical combined hardness profiles trough samples nitrided at 20%N₂ / 80%H₂ atmosphere at 700 °C, at 800 °C and at 900 °C. It is observed that the values of hardness fit very well in the hardness profile from near surface to deeper regions.

Figure 6 shows hardness, at 250 nm in depth, for all nitriding conditions summarized in Table 1. This depth was chosen because different samples temperatures and gas atmospheres produce very different nitrided depth that can change from the near surface until deeper regions (µm). From this plot it is possible to observe that the best near surface hardness improvements, from ≈ 4 GPa for bulk Ti to ≈ 23 GPa, are obtained at 900 °C independent of the plasma atmosphere. Higher elastic modulus values were also obtained for the treatment at 900 °C, ranging from ≈ 136 GPa for bulk to ≈ 300 GPa at 250 nm in depth, as shown in Figure 7.

4. Conclusions

In order to obtain hardness and elastic modulus profiles in rough surfaces, it is proposed in the present work a method based on the

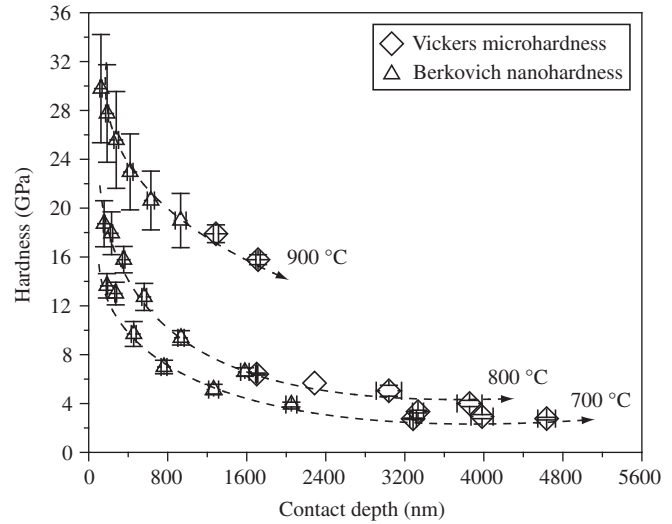


Figure 5. Hardness vs. contact depth for titanium samples nitrided at 700 °C, 800 °C and 900 °C and 20%N₂ / 80%H₂ atmosphere, corrected by the contact stiffness analysis (Δ). Vickers microhardness values are also shown (◇). The lines are a guide for the eyes.

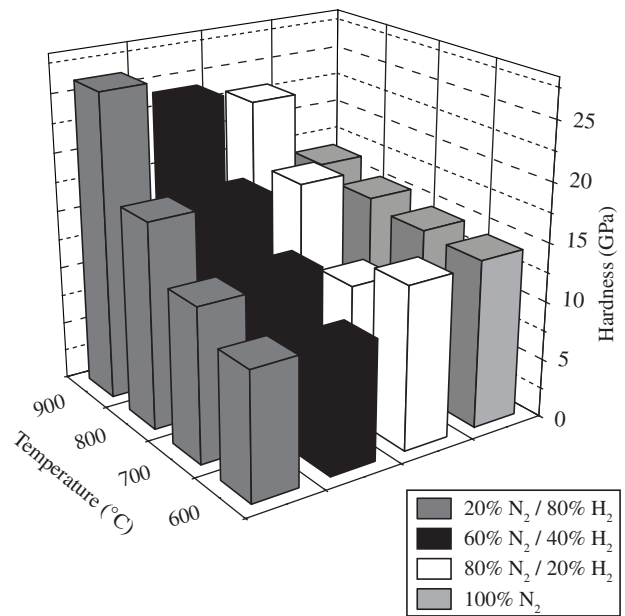


Figure 6. Hardness as a function of temperature and gaseous mixture, obtained at 250 nm in depth, for all titanium working conditions.

contact stiffness analysis. The results showed good agreement with the Odo-Lepinski method and also fit very well with microhardness (Vickers) results for deeper regions. The contact stiffness analysis allows correct the loading/unloading curves to the most correct zero surface contact point. The correction is based on the mean surface roughness value. At present work, different surface roughness degrees were obtained by nitriding Cp-Ti samples by glow discharge technique. In average, for all nitrided Ti samples, a very low surface hardness (≈ 4 GPa) was obtained when it is applied directly the Oliver and Pharr method that not takes in account the surface roughness. However, if the contact stiffness analysis is performed to correct the most probable zero surface contact point, the surface hardness change

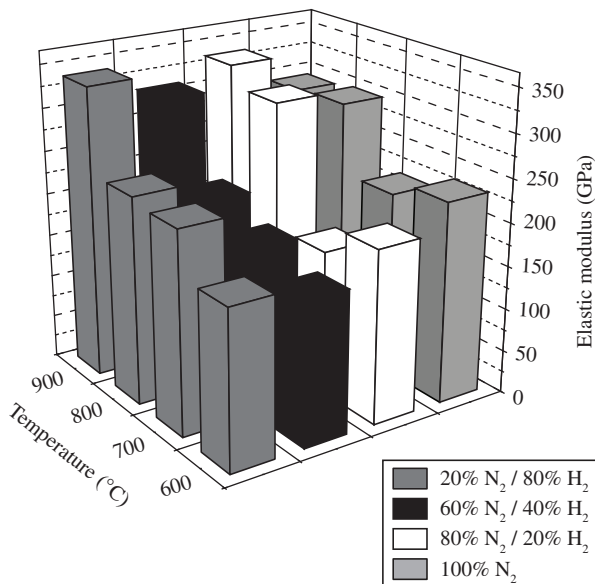


Figure 7. Elastic modulus as a function of temperature and gaseous mixture, obtained at 250 nm in depth, for all titanium working conditions.

to higher values, reaching in some working conditions 23 GPa. In the same way elastic modulus changed from 136 GPa to 300 GPa. These corrected values are in agreement with the literature data.

Consequently, if roughness is present in the surface and it is quantified, we propose that this type of contact stiffness analysis can be used for correct to the most actual zero surface contact point, and then obtain the most correct hardness and elastic modulus on rough surfaces.

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References

1. Oliver WC, Pharr GM. An improved technique for determining hardness and elastic modulus using load and displacement sensing indentation experiments. *Journal of Materials Research*. 1992; 7(6):1564-1583.
2. Brotzen FR. Mechanical testing of thin films. *International Materials Reviews*. 1994; 39(1):24-45.
3. Tsui TY, Pharr GM. Substrate effects on nanoindentation mechanical property measurement of soft films on hard substrates. *Journal of Materials Research*. 1999; 14(1):292-301.
4. Bhushan B, Gupta BK. *Handbook of tribology: materials, coatings and surface treatments*. New York: McGraw-Hill; 1991.
5. Odo GY. *Fundamentos de nanoindentação e aplicações em vidros com superfícies modificadas por migrações iônicas*. [Unpublished PhD thesis]. Curitiba, Brazil: Universidade Federal do Paraná; 2001.
6. Souza GB, Foerster CE, Silva SLR, Serbena FC, Lepiński CM, Santos CA. Hardness and elastic modulus of ion-nitrided titanium obtained by nanoindentation. *Surface & Coatings Technology*. 2005; 191:76-82.
7. Fu Y, Loh NL, Wei J, Yan B, Hing P. Friction and wear behaviour of carbon nitride films deposited on plasma nitrided Ti-6Al-4V. *Wear*. 2000; 237:12-19.
8. Metin ES, Inal OT. Microstructural and microhardness evaluations in ion nitrided titanium. *Materials Science and Engineering*. 1991; A145:65-77.
9. Raveh A, Avni R, Grill A. R.F. plasma nitriding of Ti-6Al-4V alloy. *Thin Solid Films*. 1990; 186:241-256.
10. Bell T, Bergmann HW, Lanagan J, Morton PH, Staines AM. Surface engineering of titanium with nitrogen. *Surface Engineering*. 1986; 2(2).
11. Brading HJ, Morton PH, Bell T, Earwaker LG. Plasma nitriding with nitrogen, hydrogen, and argon gas mixtures: structure and composition of coatings on titanium. *Surface Engineering*. 1992; 8(3):206-212.
12. Sundgren JE. Structure and properties of TiN coatings. *Thin Solid Films*. 1985; 128:21-44.
13. Song JF, Vorbuerger TV. Surface texture. In: ASM International Handbook Committee. *ASM Handbook*. USA: ASM. 1992; 18:334-345.
14. Bobji MS, Biswas SK. Estimation of hardness by nanoindentation of rough surfaces. *Journal of Materials Research*. 1998; 13(11):3227-3233.
15. Gouldstone A, Van Vliet KJ, Suresh S. Simulation of defect nucleation in a crystal. *Nature*. 2001 Jun 7; 411(6838):656.
16. Meyers MA, Chawla KK. *Mechanical behavior of materials*. New Jersey: Prentice Hall; 1999.